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## FAIRCHILD

## FDSS2407

N－Channel Dual MOSFET

## 62V，3．3A，132m $\Omega$

## Features

－ $62 \mathrm{~V}, 132 \mathrm{~m} \Omega$ ， 5 V Logic Level Gate Dual MOSFET in SO－8
－5V Logic Level feedback signal of the drain to source voltage．Multiple devices can be wired＂OR＇d＂to a single monitoring circuit input．
－Gate Drive Disable Input．Multiple devices controllable by a single disable transistor．

■ Qualified to AEC Q101

## Applications

－Automotive Injector Driver
－Solenoid Driver

## General Description

This dual N－Channel MOSFET provides added functions as compared to a conventional Power MOSFET．These are： 1. A drain to source voltage feedback signal and 2．A gate drive disable control function that previously required external discrete circuitry．Including these functions within the MOSFET saves printed circuit board space．The drain to source voltage feedback function provides a 5 V level output whenever the drain to source voltage is above 62 V ．This can monitor the time an inductive load takes to dissipate its stored energy．Multiple feedback signals can be wired ＂OR＇d＂together to a single input of the monitoring circuit． The gate disable function allows the device to be turned off independent of the drive signal on the gate．This function permits a second control circuit the ability to deactivate the load if necessary．It can also be wired＂OR＇d＂allowing multiple devices to be controlled by a single open collector／ drain control transistor．

MOSFET Maximum Ratings $\mathrm{T}_{\mathrm{A}}=25^{\circ} \mathrm{C}$ unless otherwise noted

| Symbol | Parameter | Ratings | Units |
| :---: | :---: | :---: | :---: |
| $\mathrm{V}_{\text {DSS }}$ | Drain to Source Voltage | 62 | V |
| $\mathrm{v}_{\mathrm{GS}}$ | Gate to Source Voltage | $\pm 20$ | V |
| $\mathrm{I}_{\mathrm{D}}$ | Drain Current <br> Continuous ( $\left.\mathrm{T}_{\mathrm{A}}=25^{\circ} \mathrm{C}, \mathrm{V}_{\mathrm{GS}}=10 \mathrm{~V}, \mathrm{R}_{\theta \mathrm{JA}}=55^{\circ} \mathrm{C} / \mathrm{W}\right)$ | 3.3 | A |
|  | Continuous ( $\left.\mathrm{T}_{\mathrm{A}}=25^{\circ} \mathrm{C}, \mathrm{V}_{\mathrm{GS}}=5 \mathrm{~V}, \mathrm{R}_{\theta \mathrm{JA}}=55^{\circ} \mathrm{C} / \mathrm{W}\right)$ | 3.0 | A |
|  | Pulsed | Figure 4 | A |
| $\mathrm{E}_{\text {AS }}$ | Single Pulse Avalanche Energy ( Note 1) | 140 | mJ |
| $\mathrm{P}_{\mathrm{D}}$ | Power dissipation | 2.27 | W |
|  | Derate above $25^{\circ} \mathrm{C}$ | 18 | $\mathrm{mW} /{ }^{\circ} \mathrm{C}$ |
| $\mathrm{T}_{\mathrm{J},} \mathrm{T}_{\text {STG }}$ | Operating and Storage Temperature | -55 to 150 | ${ }^{\circ} \mathrm{C}$ |

## Thermal Characteristics

| $\mathrm{R}_{\theta \mathrm{JA}}$ | Pad Area $=0.50 \mathrm{in}^{2}\left(323 \mathrm{~mm}^{2}\right)($ Note 2) | 55 | ${ }^{\circ} \mathrm{C} / \mathrm{W}$ |
| :--- | :--- | :---: | :---: |
| $\mathrm{R}_{\theta \mathrm{JA}}$ | Pad Area $=0.027 \mathrm{in}^{2}\left(17.4 \mathrm{~mm}^{2}\right)($ Note 3) | 180 | ${ }^{\circ} \mathrm{C} / \mathrm{W}$ |
| $\mathrm{R}_{\theta \mathrm{JA}}$ | Pad Area $=0.006 \mathrm{in}^{2}\left(3.87 \mathrm{~mm}^{2}\right)($ Note 4) | 200 | ${ }^{\circ} \mathrm{C} / \mathrm{W}$ |

## Package Marking and Ordering Information

| Device Marking | Device | Package | Reel Size | Tape Width | Quantity |
| :---: | :---: | :---: | :---: | :---: | :---: |
| 2407 | FDSS2407 | SO-8 | 330 mm | 12 mm | 2500 |

## Electrical Characteristics $\mathrm{T}_{\mathrm{A}}=25^{\circ} \mathrm{C}$ unless otherwise noted

| Symbol | Parameter | Test Conditions | Min | Typ | Max | Units |
| :--- | :--- | :--- | :--- | :--- | :--- | :--- |

Off Characteristics

| B ${ }_{\text {VDSs }}$ | Drain to Source Breakdown Voltage | $\mathrm{I}_{\mathrm{D}}=5 \mathrm{~mA}, \mathrm{~V}_{\mathrm{GS}}=0 \mathrm{~V}$ | 62 | - | - | V |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  | $\mathrm{V}_{\mathrm{DS}}=15 \mathrm{~V}, \mathrm{~V}_{\mathrm{GS}}=0 \mathrm{~V}$ | - | - | 1 |  |
| $\mathrm{I}_{\text {DSS }}$ | Zero Gate Voltage Drain Current | $\begin{aligned} & \mathrm{V}_{\mathrm{DS}}=15 \mathrm{~V}, \mathrm{~V}_{\mathrm{GS}}=0 \mathrm{~V}, \\ & \mathrm{~T}_{\mathrm{A}}=150^{\circ} \mathrm{C} \end{aligned}$ | - | - | 250 | $\mu \mathrm{A}$ |
| IGSS | Gate to Source Leakage Current | $\mathrm{V}_{\mathrm{GS}}= \pm 20 \mathrm{~V}$ | - | - | $\pm 100$ | nA |

## On Characteristics

| $\mathrm{V}_{\mathrm{GS} \text { (TH) }}$ | Gate to Source Threshold Voltage | $\mathrm{V}_{\mathrm{GS}}=\mathrm{V}_{\mathrm{DS}}, \mathrm{I}_{\mathrm{D}}=250 \mu \mathrm{~A}$ | 1 | - | 3 | V |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| ${ }^{\text {r DS(ON) }}$ | Drain to Source On Resistance | $\mathrm{I}_{\mathrm{D}}=3.3 \mathrm{~A}, \mathrm{~V}_{\mathrm{GS}}=10 \mathrm{~V}$ | - | 0.099 | 0.110 | $\Omega$ |
|  |  | $\mathrm{I}_{\mathrm{D}}=3.0 \mathrm{~A}, \mathrm{~V}_{\mathrm{GS}}=5 \mathrm{~V}$ | - | 0.115 | 0.132 |  |

## Dynamic Characteristics

| $\mathrm{C}_{\text {ISS }}$ | Input Capacitance | $\begin{aligned} & \mathrm{V}_{\mathrm{DS}}=15 \mathrm{~V}, \mathrm{~V}_{\mathrm{GS}}=0 \mathrm{~V}, \\ & \mathrm{f}=75 \mathrm{kHz} \end{aligned}$ |  | - | 300 |  | pF |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| $\mathrm{C}_{\text {OSS }}$ | Output Capacitance |  |  | - | 140 | - | pF |
| $\mathrm{C}_{\text {RSS }}$ | Reverse Transfer Capacitance |  |  |  | 16 | - | pF |
| $\mathrm{R}_{\mathrm{G}}$ | Gate Resistance |  |  |  | 8500 | - | $\Omega$ |
| $\mathrm{Q}_{\mathrm{g}(\text { TOT) }}$ | Total Gate Charge at 5V | $\mathrm{V}_{\mathrm{GS}}=0 \mathrm{~V}$ to 5 V |  |  | 3.3 | 4.3 | nC |
| $\mathrm{Q}_{\mathrm{g}(\mathrm{TH})}$ | Threshold Gate Charge | $\begin{aligned} & J V_{D D}=30 \mathrm{~V} \\ & \mathrm{I}_{\mathrm{D}}=3.3 \mathrm{~A} \\ & \mathrm{I}_{\mathrm{g}}=1.0 \mathrm{~mA} \end{aligned}$ |  | - | 0.4 | 0.5 | nC |
| $\mathrm{Q}_{\mathrm{gs}}$ | Gate to Source Gate Charge |  |  |  | 1.2 | - | nC |
| $\mathrm{Q}_{\mathrm{gs} 2}$ | Gate Charge Threshold to Plateau |  |  | - | 0.8 | - | nC |
| $\mathrm{Q}_{\mathrm{gd}}$ | Gate to Drain "Miller" Charge |  |  | - | 2.0 | - | nC |

## Switching Characteristics ( $\mathrm{V}_{\mathrm{GS}}=10 \mathrm{~V}$ )

| $\mathrm{t}_{\mathrm{ON}}$ | Turn-On Time | $\begin{aligned} & \mathrm{V}_{\mathrm{DD}}=30 \mathrm{~V}, \mathrm{I}_{\mathrm{D}}=3.3 \mathrm{~A} \\ & \mathrm{~V}_{\mathrm{GS}}=10 \mathrm{~V}, \mathrm{R}_{\mathrm{GS}}=47 \Omega \end{aligned}$ | - | - | 2700 | ns |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| $\mathrm{t}_{\mathrm{d}(\mathrm{ON})}$ | Turn-On Delay Time |  | - | 630 | - | ns |
| $\mathrm{t}_{\mathrm{r}}$ | Rise Time |  | - | 1200 | - | ns |
| $\mathrm{t}_{\mathrm{d} \text { (OFF) }}$ | Turn-Off Delay Time |  | - | 8700 | - | ns |
| $\mathrm{t}_{\mathrm{f}}$ | Fall Time |  | - | 3500 | - | ns |
| tofF | Turn-Off Time |  | - | - | 18500 | ns |

Drain-Source Diode Characteristics

| $\mathrm{V}_{\mathrm{SD}}$ | Source to Drain Diode Voltage | $\mathrm{I}_{\mathrm{SD}}=3.3 \mathrm{~A}$ | - | - | 1.25 | V |
| :--- | :--- | :--- | :---: | :---: | :---: | :---: |
|  |  | $\mathrm{I}_{\mathrm{SD}}=1.7 \mathrm{~A}$ | - | - | 1.0 | V |
| $\mathrm{t}_{\mathrm{rr}}$ | Reverse Recovery Time | $\mathrm{I}_{\mathrm{SD}}=3.3 \mathrm{~A}, \mathrm{dl} / \mathrm{dD}=100 \mathrm{~A} / \mu \mathrm{s}$ | - | - | 45 | ns |
| $\mathrm{Q}_{\mathrm{RR}}$ | Reverse Recovered Charge | $\mathrm{I}_{\mathrm{SD}}=3.3 \mathrm{~A}, \mathrm{dISD} / \mathrm{dt}=100 \mathrm{~A} / \mu \mathrm{s}$ | - | - | 60 | nC |

Drain Feedback Characteristics

| $\mathrm{V}_{\mathrm{FBK}(\text { Low })}$ | Feedback to Source Voltage | $\mathrm{V}_{\mathrm{DS}}=35 \mathrm{~V}, \mathrm{R}_{\mathrm{FBK} \text {-SOURCE }}=51 \mathrm{~K} \Omega$ | - | 1 | 1.5 | V |
| :--- | :--- | :--- | :---: | :---: | :---: | :---: |
| $\mathrm{~V}_{\mathrm{FBK}(\text { High })}$ | Feedback to Source Voltage | $\mathrm{V}_{\mathrm{DS}}=62 \mathrm{~V}, \mathrm{R}_{\text {FBK-SOURCE }}=51 \mathrm{~K} \Omega$ | 3.5 | 4.4 | - | V |

## Gate Drive Disable Characteristics

| $\mathrm{V}_{\mathrm{DIS} \text { (High) }}$ | Gate Drive Disable Input Voltage, Gate <br> Enabled | $\mathrm{V}_{\mathrm{GS}}=5 \mathrm{~V}, \mathrm{I}_{\mathrm{D}}=3.0 \mathrm{~A}, \mathrm{~T}_{\mathrm{J}}=25^{\circ} \mathrm{C}$ | 3 | - | - | V |
| :---: | :--- | :--- | :---: | :---: | :---: | :---: |
| $\mathrm{V}_{\text {DIS(Low) }}$ | Gate Drive Disable Input Voltage, Gate <br> Disabled | $\mathrm{V}_{\mathrm{GS}}=\mathrm{V}_{\mathrm{DS}}=10 \mathrm{~V}, \mathrm{I}_{\mathrm{D}} \leq 250 \mu \mathrm{~A}$, <br> $\mathrm{T}_{\mathrm{J}}=150^{\circ} \mathrm{C}$ | - | - | 0.4 | V |

## Notes:

1. Starting $\mathrm{T}_{\mathrm{J}}=25^{\circ} \mathrm{C}, \mathrm{L}=42 \mathrm{mH}, \mathrm{I}_{\mathrm{AS}}=2.6 \mathrm{~A}, \mathrm{~V}_{\mathrm{DD}}=62 \mathrm{~V}, \mathrm{~V}_{\mathrm{GS}}=10 \mathrm{~V}$
2. $55^{\circ} \mathrm{C} / \mathrm{W}$ measured using FR-4 board with $0.50 \mathrm{in}^{2}\left(323 \mathrm{~mm}^{2}\right)$ copper pad at 1 second
3. $180^{\circ} \mathrm{C} / \mathrm{W}$ measured using FR-4 board with $0.027 \mathrm{in}^{2}\left(17.4 \mathrm{~mm}^{2}\right)$ copper pad at 1000 seconds.
4. $200^{\circ} \mathrm{C} / \mathrm{W}$ measured using FR-4 board with $0.006 \mathrm{in}^{2}\left(3.87 \mathrm{~mm}^{2}\right)$ copper pad at 1000 seconds.

This product has been designed to meet the extreme test conditions and environment demanded by the automotive industry. For a copy of the requirements, see AEC Q101 at: http://www.aecouncil.com/ All Fairchild Semiconductor products are manufactured, assembled and tested under ISO9000 and QS9000 quality systems certification.

Typical Characteristics $\mathrm{T}_{\mathrm{A}}=25^{\circ} \mathrm{C}$ unless otherwise noted


Figure 1．Normalized Power Dissipation vs Ambient Temperature


Figure 2．Maximum Continuous Drain Current vs Ambient Temperature


Figure 3．Normalized Maximum Transient Thermal Impedance


Figure 4．Peak Current Capability

Typical Characteristics（Continued） $\mathrm{T}_{\mathrm{A}}=25^{\circ} \mathrm{C}$ unless otherwise noted


Figure 5．Forward Bias Safe Operating Area


Figure 7．Transfer Characteristics


Figure 9．Drain to Source On Resistance vs Gate Voltage and Drain Current


NOTE：Refer to Fairchild Application Notes AN7514 and AN7515 Figure 6．Unclamped Inductive Switching Capability


Figure 8．Saturation Characteristics


Figure 10．Normalized Drain to Source On Resistance vs Junction Temperature

Typical Characteristics (Continued) $\mathrm{T}_{\mathrm{A}}=25^{\circ} \mathrm{C}$ unless otherwise noted


Figure 11. Normalized Gate Threshold Voltage vs Junction Temperature


Figure 13. Feedback Voltage vs Drain to Source Voltage


Figure 15. Drain to Source On Resistance vs Gate Disable Voltage


Figure 12. Normalized Drain to Source Breakdown Voltage vs Junction Temperature


Figure 14. Capacitance vs Drain to Source Voltage


Figure 16. Gate to Source Voltage vs Gate Disable Voltage

## Typical Characteristics（Continued） $\mathrm{T}_{\mathrm{A}}=25^{\circ} \mathrm{C}$ unless otherwise noted



Figure 17．Gate Charge Waveforms for Constant Gate Currents
Test Circuits and Waveforms


Figure 18．Unclamped Energy Test Circuit


Figure 20．Gate Charge Test Circuit


Figure 19．Unclamped Energy Waveforms


Figure 21．Gate Charge Waveforms


Figure 22. Switching Time Test Circuit


Figure 23. Switching Time Waveforms


Figure 24. Gate to Source Voltage vs Gate Disable Voltage

## Thermal Resistance vs．Mounting Pad Area

The maximum rated junction temperature， $\mathrm{T}_{\mathrm{JM}}$ ，and the thermal resistance of the heat dissipating path determines the maximum allowable device power dissipation， $\mathrm{P}_{\mathrm{DM}}$ ，in an application．Therefore the application＇s ambient temperature， $\mathrm{T}_{\mathrm{A}}\left({ }^{\circ} \mathrm{C}\right)$ ，and thermal resistance $\mathrm{R}_{\theta \mathrm{JA}}\left({ }^{\circ} \mathrm{C} / \mathrm{W}\right)$ must be reviewed to ensure that $\mathrm{T}_{\mathrm{JM}}$ is never exceeded． Equation 1 mathematically represents the relationship and serves as the basis for establishing the rating of the part．

$$
\begin{equation*}
P_{D M}=\frac{\left(T_{J M}-T_{A}\right)}{R_{\theta J A}} \tag{EQ.1}
\end{equation*}
$$

In using surface mount devices such as the SO8 package， the environment in which it is applied will have a significant influence on the part＇s current and maximum power dissipation ratings．Precise determination of $P_{D M}$ is complex and influenced by many factors：

1．Mounting pad area onto which the device is attached and whether there is copper on one side or both sides of the board．
2．The number of copper layers and the thickness of the board．
3．The use of external heat sinks．
4．The use of thermal vias．
5．Air flow and board orientation．
6．For non steady state applications，the pulse width，the duty cycle and the transient thermal response of the part， the board and the environment they are in．
Fairchild provides thermal information to assist the designer＇s preliminary application evaluation．Figure 25 defines the $R_{\theta J A}$ for the device as a function of the top copper（component side）area．This is for a horizontally positioned FR－4 board with $10 z$ copper after 1000 seconds of steady state power with no air flow．This graph provides the necessary information for calculation of the steady state junction temperature or power dissipation．Pulse applications can be evaluated using the Fairchild device Spice thermal model or manually utilizing the normalized
maximum transient thermal impedance curve．
Thermal resistances corresponding to other copper areas can be obtained from Figure 25 or by calculation using Equation 2．The area，in square inches is the top copper area including the gate and source pads．

$$
\begin{equation*}
R_{\theta J A}=79.9+\frac{15}{0.14+\text { Area }} \tag{EQ.2}
\end{equation*}
$$

The transient thermal impedance $\left(\mathrm{Z}_{\theta \mathrm{JA}}\right)$ is also effected by varied top copper board area．Figure 26 shows the effect of copper pad area on single pulse transient thermal impedance．Each trace represents a copper pad area in square inches corresponding to the descending list in the graph．Spice and SABER thermal models are provided for each of the listed pad areas．

Copper pad area has no perceivable effect on transient thermal impedance for pulse widths less than 100 ms ．For pulse widths less than 100 ms the transient thermal impedance is determined by the die and package． Therefore，CTHERM1 through CTHERM5 and RTHERM1 through RTHERM5 remain constant for each of the thermal models．A listing of the model component values is available in Table 1.


Figure 25．Thermal Resistance vs Mounting Pad Area


Figure 26．Thermal Impedance vs Mounting Pad Area

## PSPICE Electrical Model

．SUBCKT FDSS2407 213101102 ；rev July 2004
Ca 128 1e－10
Cb $15144 \mathrm{e}-10$
Cin 68 2．8e－10
Dbody 75 DbodyMOD
Dbreak 511 DbreakMOD
Dplcap 105 DplcapMOD
CGATE 920 5e－9
DDISABLE 20101 DDISABLEMOD
DFBK1 104103 DFBK1MOD
DFBK2 7104 DFBK2MOD
DFBK3 104102 DFBK3MOD
RFBK1 5103 RFBK1MOD 13e3
RFBK2 1047 RFBK2MOD 2.15 e 3
Ebreak 117171867.4
Eds 148581
Egs 138681
Esg 610681
Evthres 6211981
Evtemp 20618221
It 8171
Lgate 19 1．8e－9
Ldrain 25 1．0e－9
Lsource 37 0．6e－9
RLgate 1918
RLdrain 2510
RLsource 376
Mmed 16688 MmedMOD
Mstro 16688 MstroMOD
Mweak 162188 MweakMOD
Rbreak 1718 RbreakMOD 1
Rdrain 5016 RdrainMOD 3．5e－2
Rgate 920 RgateMOD 8．63e3
RSLC1 551 RSLCMOD 1e－6
RSLC2 550 1e3
Rsource 87 RsourceMOD 5．3e－2
Rvthres 228 RvthresMOD 1
Rvtemp 1819 RvtempMOD 1
S1a 612138 S1AMOD
S1b 1312138 S1BMOD
S2a 6151413 S2AMOD
S2b 13151413 S2BMOD
Vbat 2219 DC 1
ESLC 5150 VALUE $=\left\{(\mathrm{V}(5,51) / \operatorname{ABS}(\mathrm{V}(5,51)))^{*}(\operatorname{PWR}(\mathrm{~V}(5,51) /(1 \mathrm{e}-6 * 20), 3.5))\right\}$
．MODEL DbodyMOD D $(\mathrm{IS}=1.1 \mathrm{E}-12 \mathrm{~N}=1.05 \mathrm{IKF}=4 \mathrm{e}-1 \quad \mathrm{RS}=4.2 \mathrm{e}-2$ TRS $1=3 \mathrm{e}-4$ TRS2＝1．3e－6
＋CJO＝3．3e－10 TT＝3e－8 $\mathrm{M}=0.38, \mathrm{XTI}=3.5$ ）
．MODEL DbreakMOD D（RS＝1 TRS1＝1e－3 TRS2＝－9e－6）
．MODEL DplcapMOD D（CJO＝1．97e－10 IS $=1 \mathrm{e}-30 \mathrm{~N}=10 \mathrm{M}=0.84$ ）
．MODEL DDISABLEMOD D（RS＝30 IS＝1e－15 BV＝4．7 TBV1＝－3e－4 TBV2＝－3e－6 XTI＝0）
．MODEL DFBK1MOD D（IS＝1e－15 BV＝23．8 IKF＝2 TBV1＝－6e－4 TBV2＝6e－6）
．MODEL DFBK2MOD D（RS＝1 IS＝1e－30 BV＝5．6 N＝3．3 NBV＝1）
．MODEL DFBK3MOD D（RS＝1 IS＝1e－15 BV＝4．2 NBV＝2．5）
．MODEL MmedMOD NMOS（VTO＝1．7 KP＝1．08 IS＝1e－30 N＝10 TOX＝1 L＝1u W＝1u RG＝8．56e3）
．MODEL MstroMOD NMOS（VTO＝2 KP＝14 IS＝1e－30 N＝10 TOX＝1 L＝1u W＝1u）
．MODEL MweakMOD NMOS（VTO＝1．5 kp＝0．04 IS＝1e－30 N＝10 TOX＝1 L＝1u W＝1u RG＝8．56e4 RS＝0．1）
．MODEL RbreakMOD RES（TC1＝1．05e－3 TC2＝－9e－7）
．MODEL RdrainMOD RES（TC1＝9e－3 TC2＝2．7e－5）
．MODEL RSLCMOD RES（TC1＝2e－3 TC2＝6e－6）
．MODEL RsourceMOD RES（TC1＝3e－3 TC2＝1e－6）
．MODEL RvthresMOD RES（TC1＝－1．1e－3 TC2＝－3．3e－6）
．MODEL RvtempMOD RES（TC1＝－1．6e－3 TC2＝1e－7）
．MODEL RFBK1MOD RES（TC1＝－1．4e－3 TC2＝1e－6）
．MODEL RFBK2MOD RES（TC1＝－1．4e－3 TC2＝1e－6）
．MODEL RgateMOD RES（TC1＝－1．4e－3 TC2＝1e－5）
．MODEL S1AMOD VSWITCH（RON＝1e－5 ROFF＝0．1 VON＝－4．0 VOFF＝－3．0）
．MODEL S1BMOD VSWITCH（RON＝1e－5 ROFF＝0．1 VON＝－3．0 VOFF＝－4．0）
．MODEL S2AMOD VSWITCH（RON＝1e－5 ROFF＝0．1 VON＝－1．0 VOFF＝－0．5）
．MODEL S2BMOD VSWITCH（RON＝1e－5 ROFF＝0．1 VON＝－0．5 VOFF＝－1．0）
．ENDS

[^1]
## SABER Electrical Model

REV July 2004
template FDSS2407 n2,n1,n3,n101,n102
electrical n2, n1, n3, n101, n102
\{
var i iscl
dp..model dbodymod $=(i s l=1.1 \mathrm{e}-12, \mathrm{nl}=1.05, \mathrm{ikf}=4 \mathrm{e}-1, \mathrm{rs}=4.2 \mathrm{e}-2, \operatorname{trs} 1=3 \mathrm{e}-4, \mathrm{trs} 2=1.3 \mathrm{e}-6, \mathrm{cjo}=3.3 \mathrm{e}-10, \mathrm{tt}=3 \mathrm{e}-8, \mathrm{~m}=0.38, \mathrm{xti}=3.5)$ dp..model dbreakmod $=(r s=1$, trs $1=1 e-3$, trs2 $=-9 e-6)$
dp..model ddisablemod $=(r s=30$, isl= $1 e-15, b v=4.7, t b v 1=-3 e-4, t b v 2=-3 e-6, x t i=0)$
dp.. model dfbk1mod $=($ isl $=1 \mathrm{e}-15, \mathrm{bv}=23.8, \mathrm{ikf}=2, \mathrm{tbv} 1=-6 \mathrm{e}-4, \mathrm{tbv} 2=6 \mathrm{e}-6)$
dp..model dfbk2mod $=(r s=1$, isl=1e-30,bv=5.6,nl=3.3,nbv=1)
dp..model dfbk3mod $=(r s=1$, isl=1e-15, bv=4.2,nbv=2.5)
dp..model dplcapmod $=(\operatorname{cjo}=1.97 \mathrm{e}-10$, is $l=10 \mathrm{e}-30, \mathrm{nl}=10, \mathrm{~m}=0.84)$
m..model mmedmod $=\left(\right.$ type $=\_\mathrm{n}, \mathrm{vto}=1.7, \mathrm{kp}=1.08$, is $=1 \mathrm{e}-30$, tox $\left.=1\right)$
$\mathrm{m} .$. model $\mathrm{mstrongmod}=\left(\right.$ type $=\_\mathrm{n}, \mathrm{vto}=2, \mathrm{kp}=14$, is $=1 \mathrm{e}-30$, tox $\left.=1\right)$
m..model mweakmod $=\left(\right.$ type $=\_\mathrm{n}, \mathrm{vto}=1.5, \mathrm{kp}=0.04$, is $=1 \mathrm{e}-30$, tox $\left.=1, \mathrm{rs}=0.1\right)$
m.mmed n16 n6 n8 n8 = model=mmedmod, $\mathrm{l}=1 \mathrm{u}, \mathrm{w}=1 \mathrm{u}$
m.mstrong n16 n6 n8 n8 = model=mstrongmod, $\mathrm{l}=1 \mathrm{u}, \mathrm{w}=1 \mathrm{u}$
m.mweak n16 n21 n8 n8 = model=mweakmod, $\mathrm{l}=1 \mathrm{u}, \mathrm{w}=1 \mathrm{u}$
sw_vcsp..model s1amod $=($ ron $=1 \mathrm{e}-5$, roff $=0.1$, von $=-4.0$, voff $=-3.0)$
sw_vcsp..model s1bmod $=($ ron=1e-5,roff=0.1,von=-3.0,voff=-4.0)
sw_vcsp..model s2amod $=($ ron $=1 \mathrm{e}-5$, roff $=0.1$, von $=-1.0$, voff $=-0.5)$
sw_vcsp..model s2bmod $=(r o n=1 e-5, r o f f=0.1$, von $=-0.5$, voff $=-1.0)$
c.ca $\mathrm{n} 12 \mathrm{n} 8=1 \mathrm{e}-10$
c.cb n15 n14 $=4 \mathrm{e}-10$
c. $\operatorname{cin} \mathrm{n} 6 \mathrm{n} 8=2.8 \mathrm{e}-10$
c.cgate n9 n20 $=5 \mathrm{e}-9$
dp.dbody n7 n5 = model=dbodymod dp.dbreak n5 n11 = model=dbreakmod dp.dplcap n10 n5 = model=dplcapmod dp.ddisable n20 n101 = model=ddisablemod dp.dfbk1 n104 n103 = model=dfbk1mod dp.dfbk2 n7 n104 = model=dfbk2mod dp.dfbk3 n104 n102 = model=dfbk3mod spe.ebreak n11 n7 n17 n18 $=67.4$ spe.eds n14 n8 n5 n8 = 1 spe.egs $n 13 \mathrm{n} 8 \mathrm{n} 6 \mathrm{n} 8=1$ spe.esg n6 n10 n6 n8 = 1 spe.evthres n6 n21 n19 n8 = 1 spe.evtemp n20 n6 n18 n22 = 1
i.it n8 n17 = 1
I.Igate $\mathrm{n} 1 \mathrm{n} 9=1.8 \mathrm{e}-9$
I.Idrain n2 n5 = 1.0e-9 I.Isource n3 n7 $=0.6 \mathrm{e}-9$ res.rlgate $\mathrm{n} 1 \mathrm{n} 9=18$ res.rldrain n2 n5 $=10$ res. rlsource $\mathrm{n} 3 \mathrm{n} 7=6$ res.rbreak n17 n18 = 1, tc1=1.05e-3,tc2=-9e-7 res.rdrain n50 n16 $=3.5 \mathrm{e}-2, \mathrm{tc} 1=9 \mathrm{e}-3, \mathrm{tc} 2=2.7 \mathrm{e}-5$ res.rgate $\mathrm{n} 9 \mathrm{n} 20=8.63 \mathrm{e} 3, \mathrm{tc} 1=-1.4 \mathrm{e}-3, \mathrm{tc} 2=1 \mathrm{e}-5$ res.rfbk1 n5 n103 $=13 \mathrm{e} 3$, tc $1=-1.4 \mathrm{e}-3, \mathrm{tc} 2=1 \mathrm{e}-6$ res.rfbk2 $\mathrm{n} 104 \mathrm{n} 7=2.15 \mathrm{e} 3, \mathrm{tc} 1=-1.4 \mathrm{e}-3, \mathrm{tc} 2=1 \mathrm{e}-6$ res.rslc1 n5 n51 = 1e-6,tc1=2e-3,tc2=6e-6 res.rslc2 n5 n50 = 1e3

res.rsource $\mathrm{n} 8 \mathrm{n} 7=5.3 \mathrm{e}-2, \mathrm{tc} 1=3 \mathrm{e}-3, \mathrm{tc} 2=1 \mathrm{e}-6$
res.rvthres n22 n8 $=1$, tc $1=-1.1 \mathrm{e}-3, \mathrm{tc} 2=-3.3 \mathrm{e}-6$
res.rvtemp n18 n19 $=1$, tc $1=-1.6 \mathrm{e}-3, \mathrm{tc} 2=1 \mathrm{e}-7$
sw_vcsp.s1a n6 n12 n13 n8 = model=s1amod
sw_vcsp.s1b n13 n12 n13 n8 = model=s1bmod
sw_vcsp.s2a n6 n15 n14 n13 = model=s2amod
sw_vcsp.s2b n13 n15 n14 n13 = model=s2bmod
v.vbat n22 n19 = dc=1
equations \{
i (n51->n50) +=iscl
iscl: $v(n 51, n 50)=\left((v(n 5, n 51) /(1 e-9+a b s(v(n 5, n 51))))^{*}\left(\left(a b s\left(v(n 5, n 51)^{*} 1 e 6 / 20\right)\right)^{\star *} 3.5\right)\right)$
\}
\}

## SPICE Thermal Model

REV July 2004
FDSS2407T
Copper Area $=0.5$ in $^{2}$
CTHERM1 Junction c2 1.2e-4
CTHERM2 c2 c3 2e-3
CTHERM3 c3 c4 2e-2
CTHERM4 c4 c5 3.0e-2
CTHERM5 c5 c6 4e-2
CTHERM6 c6 c7 7e-2
CTHERM7 c7 c8 2e-1
CTHERM8 c8 Ambient 2.8

RTHERM1 Junction c2 1.4
RTHERM2 c2 c3 2.0
RTHERM3 c3 c4 2.8
RTHERM4 c4 c5 9.0
RTHERM5 c5 c6 18.0
RTHERM6 c6 c7 26.0
RTHERM7 c7 c8 28.0
RTHERM8 c8 Ambient 29.0

## SABER Thermal Model

Copper Area $=0.5$ in $^{2}$
template thermal_model th tl thermal_c th, tl
\{
ctherm.ctherm1 th $\mathrm{c} 2=1.2 \mathrm{e}-4$
ctherm.ctherm2 c2 c3 $=2 \mathrm{e}-3$
ctherm.ctherm3 c3 c4 $=2 \mathrm{e}-2$
ctherm.ctherm4 c4 c5 $=3.0 \mathrm{e}-2$
ctherm.ctherm 5 c5 c6 $=4 \mathrm{e}-2$
ctherm.ctherm6 c6 c7 $=7 \mathrm{e}-2$
ctherm.ctherm7 c7 c8 $=2 \mathrm{e}-1$
ctherm. ctherm8 c8 tl =2.8
rtherm. rtherm1 th $\mathrm{c} 2=1.4$
rtherm.rtherm2 c2 c3 $=2.0$
rtherm. rtherm3 c3 c4 $=2.8$
rtherm.rtherm4 c4 c5 $=9.0$
rtherm. rtherm5 c5 c6 $=18.0$
rtherm. rth erm6 c6 c7 $=26.0$
rtherm. rtherm7 c7 c8 =28.0
rtherm.rtherm8 $\mathrm{c} 8 \mathrm{tl}=29.0$
\}


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| :---: | :---: | :---: | :---: | :---: |
| ActiveArray ${ }^{\text {TM }}$ | $\mathrm{FAST}^{\text {® }}$ | IntelliMAX ${ }^{\text {™ }}$ | Power247 ${ }^{\text {т }}$ | SuperFET ${ }^{\text {TM }}$ |
| Bottomless ${ }^{\text {™ }}$ | FASTr ${ }^{\text {TM }}$ | ISOPLANAR ${ }^{\text {TM }}$ | PowerEdge ${ }^{\text {TM }}$ | SuperSOT ${ }^{\text {TM }}$-3 |
| CoolFET ${ }^{\text {TM }}$ | FPS ${ }^{\text {TM }}$ | LittleFET ${ }^{\text {тM }}$ | PowerSaver ${ }^{\text {TM }}$ | SuperSOTTM-6 |
| CROSSVOLT ${ }^{\text {m }}$ | FRFET ${ }^{\text {TM }}$ | MICROCOUPLER ${ }^{\text {TM }}$ | PowerTrench ${ }^{\circledR}$ | SuperSOTTM-8 |
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[^1]:    Note：For further discussion of the PSPICE model，consult A New PSPICE Sub－Circuit for the Power MOSFET Featuring Global Temperature Options；IEEE Power Electronics Specialist Conference Records，1991，written by William J．Hepp and C．Frank Wheatley．

